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				Application Number	10/571,069-Conf. #2459		
11	NFORMATION	I DI	SCLOSURE	Filing Date	December 7, 2006		
S	TATEMENT I	3Y /	APPLICANT	First Named Inventor	Hidemi KURIHARA		
				Art Unit	1649		
	(Use as many sh	eets a	necessary)	Examiner Name	S. N. MacFarlane		
Sheet	1	of	1	Attorney Docket Number	0230-0245PUS1		

	U.S. PATENT DOCUMENTS							
Examiner Initials*	Cite No.1	Document Number Number-Kind Code ² (# known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear			

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		NON PATENT LITERATURE DOCUMENTS	
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	CA	Bu et al., J. Modern Stomatol, Vol. 16, No. 1, pp.21-23 (January 2002)	
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